# SK 115 MD 10



## **MOSFET Module**

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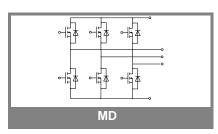
**Preliminary Data** 

### **Features**

- · Compact design
- · One screw mounting
- · Heat transfer and isolation through direct copper bonding aluminium oxide ceramic (DBC)
- Trench-gate technologyShort internal connections and low inductance case

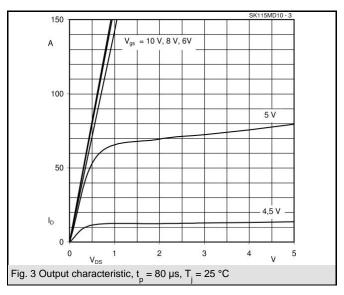
## **Typical Applications\***

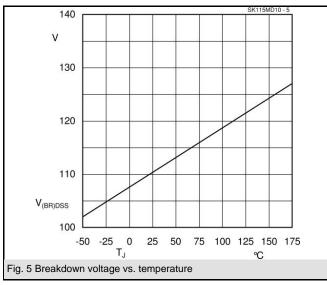
- Low switched mode power supplies
- DC servo drives
- UPS
- 1) Maximum PCB temperature, at pins contact, = 85°C

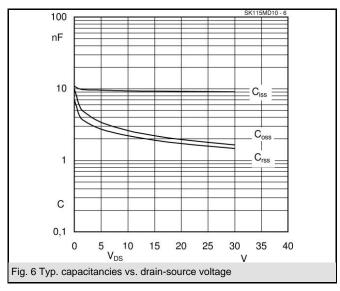


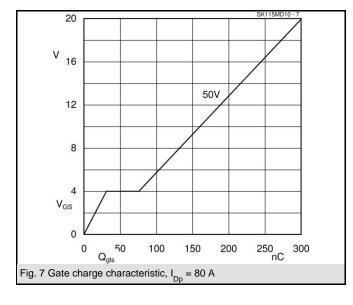
| <b>Absolute Maximum Ratings</b> $T_s = 25  ^{\circ}\text{C}$ , unless otherwise specifie |   |                   |       |  |  |  |  |  |
|--|---|-------------------|-------|--|--|--|--|--|
| Symbol   | Conditions  | Values            | Units |  |  |  |  |  |
| MOSFET   |   |                   |       |  |  |  |  |  |
| $V_{DSS}$  |   | 100               | V     |  |  |  |  |  |
| $V_{GSS}$  |   | ± 20              | V     |  |  |  |  |  |
| I <sub>D</sub>   | $T_s = 25 (80) ^{\circ}C; 1)$                     | 80 (60)           | Α     |  |  |  |  |  |
| I <sub>DM</sub>  | $t_p < 1 \text{ ms; } T_s = (80) \text{ °C; } 1)$ | (120)             | Α     |  |  |  |  |  |
| T <sub>j</sub>   |   | - 40 <b>+</b> 150 | °C    |  |  |  |  |  |
| Inverse diode  |   |                   |       |  |  |  |  |  |
| $I_F = -I_D$   | T <sub>s</sub> = 25 (80) °C;                      | 80 (60)           | Α     |  |  |  |  |  |
| $I_{FM} = -I_{DM}$   | $t_p < 1 \text{ ms}; T_s = (80) ^{\circ}C;$       | (120)             | Α     |  |  |  |  |  |
| T <sub>j</sub>   |   | - 40 <b>+</b> 150 | °C    |  |  |  |  |  |
| Freewheeling CAL diode   |   |                   |       |  |  |  |  |  |
| $I_F = -I_D$   | $T_s = ^{\circ}C$                                 |                   | Α     |  |  |  |  |  |
| T <sub>j</sub>   |   |                   | °C    |  |  |  |  |  |
| T <sub>stg</sub>   |   | - 40 <b>+</b> 125 | °C    |  |  |  |  |  |
| T <sub>sol</sub>   | Terminals, 10 s                                   | 260               | °C    |  |  |  |  |  |
| V <sub>isol</sub>  | AC, 1 min (1s)                                    | 2500 / 3000       | V     |  |  |  |  |  |

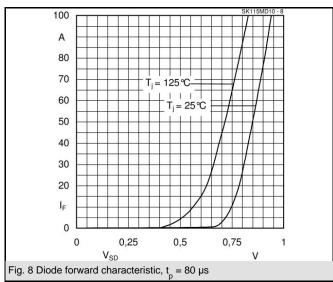
| Charact                                 | eristics   | T <sub>s</sub> = 25 °C, | T <sub>s</sub> = 25 °C, unless otherwise specified |      |          |  |  |
|---|--|-------------------------|--|------|----------|--|--|
| Symbol                                  | Conditions   | min.                    | typ.   | max. | Units    |  |  |
| MOSFET                                  |  |                         |  |      |          |  |  |
| V <sub>(BR)DSS</sub>                    | $V_{GS} = 0 \text{ V}, I_{D} = 5.6 \text{ mA}$   | 100                     |  |      | V        |  |  |
| V <sub>GS(th)</sub>                     | $V_{GS} = V_{DS}$ ; $I_D = 5.6 \text{ mA}$   | 2,5                     | 3,3  | 100  | V        |  |  |
| I <sub>DSS</sub>                        | $V_{GS} = 0 \text{ V}; V_{DS} = V_{DSS}; T_j = 25 \text{ °C}$<br>$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0 \text{ V}$ |                         |  | 100  | μA<br>nA |  |  |
| I <sub>GSS</sub><br>R <sub>DS(on)</sub> | $I_D = 80 \text{ A}; V_{GS} = 10 \text{ V}; T_i = 25 \text{ °C}$   |                         |  | 7,5  | mΩ       |  |  |
| R <sub>DS(on)</sub>                     | $I_D = 80 \text{ A; } V_{GS} = 10 \text{ V; } T_i = 125 \text{ °C}$  |                         |  | 13,5 | mΩ       |  |  |
| C <sub>CHC</sub>                        | per MOSFET   |                         |  | -,-  | pF       |  |  |
| C <sub>iss</sub>                        | under following conditions:  |                         | 9,1  |      | nF       |  |  |
| C <sub>oss</sub>                        | V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz   |                         | 1,8  |      | nF       |  |  |
| C <sub>rss</sub>                        |  |                         | 1,6  |      | nF       |  |  |
| L <sub>DS</sub>                         |  |                         |  |      | nH       |  |  |
| t <sub>d(on)</sub>                      | under following conditions:  |                         | 300  |      | ns       |  |  |
| t <sub>r</sub> `´                       | $V_{DD} = 50 \text{ V}; V_{GS} = 10 \text{ V};$<br>$I_{D} = 50 \text{ A}$  |                         | 150  |      | ns       |  |  |
| $t_{d(off)}$                            | $R_G = 56 \Omega$  |                         | 1600   |      | ns       |  |  |
| t <sub>f</sub>                          |  |                         | 160  |      | ns       |  |  |
| $R_{th(j-s)}$                           | per MOSFET (per module)  |                         |  | 1,1  | K/W      |  |  |
| Inverse                                 | diode  |                         |  |      |          |  |  |
| $V_{SD}$                                | $I_F = 50 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 50 \text{ °C}$  |                         | 0,9  |      | V        |  |  |
| I <sub>RRM</sub>                        | under following conditions:  |                         | 24   |      | Α        |  |  |
| $Q_{rr}$                                | $I_F = 50 \text{ A}; T_{vj} = 25 \text{ °C}; R_G = 56 \Omega$  |                         | 0,9  |      | μC       |  |  |
| t <sub>rr</sub>                         | V <sub>R</sub> = 65 A; di/dt = 100 A/μs  |                         | 70   |      | ns       |  |  |
| Free-wh                                 | eeling diode   |                         |  |      |          |  |  |
| V <sub>F</sub>                          | $I_F = A; V_{GS} = V$  |                         |  |      | V        |  |  |
| I <sub>RRM</sub>                        | under following conditions:  |                         |  |      | Α        |  |  |
| Q <sub>rr</sub>                         | $I_F = A; T_{vj} = ^{\circ}C$  |                         |  |      | μC       |  |  |
| t <sub>rr</sub>                         | $V_r = A$ ; di/dt = A/ $\mu$ s   |                         |  |      | ns       |  |  |
|   | ical data  |                         |  |      | •        |  |  |
| M1                                      | mounting torque  |                         |  | 2,5  | Nm       |  |  |
| w                                       |  |                         | 20   |      | g        |  |  |
| Case                                    | SEMITOP® 3   |                         | T 16   |      |          |  |  |

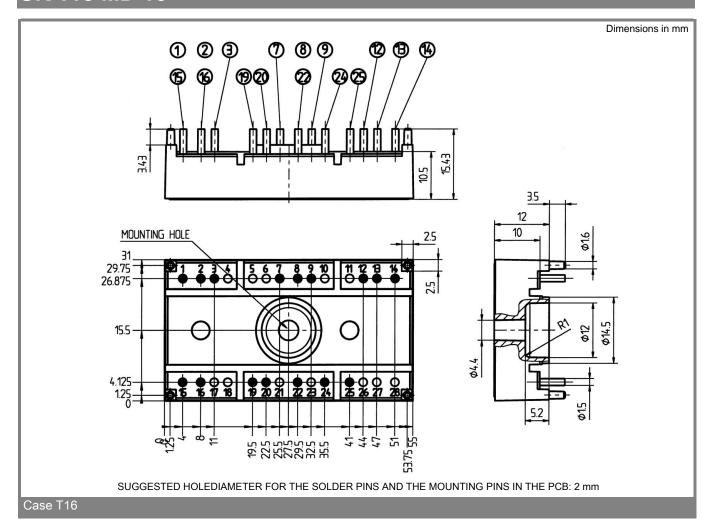


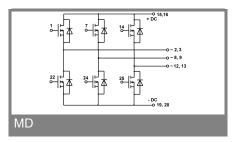












This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.